Search Notes

	Application/Control No.	Applicant(s)/Pate Reexamination	ent under
	10/763,784	APPLETON ET	AL.
	Examiner	Art Unit	
_	David E. Martinez	2181	

	SEARCHED				
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	<u>.</u>				

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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East see attached	6/19/2006	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, JPO, Derwent, IBM_TDB.	6/19/2006	DM
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